

## New England Biolabs Certificate of Analysis

**Product Name:** Styl-HF®  
**Catalog Number:** R3500L  
**Concentration:** 20,000 U/ml  
**Unit Definition:** One unit is defined as the amount of enzyme required to digest 1 µg of Lambda DNA in 1 hour at 37°C in a total reaction volume of 50 µl.  
**Packaging Lot Number:** 10175015  
**Expiration Date:** 12/2024  
**Storage Temperature:** -20°C  
**Storage Conditions:** 50 mM NaCl, 10 mM Tris-HCl (pH 7.4), 1 mM DTT, 0.1 mM EDTA, 50% Glycerol, 200 µg/ml BSA  
**Specification Version:** PS-R3500S/L v1.0

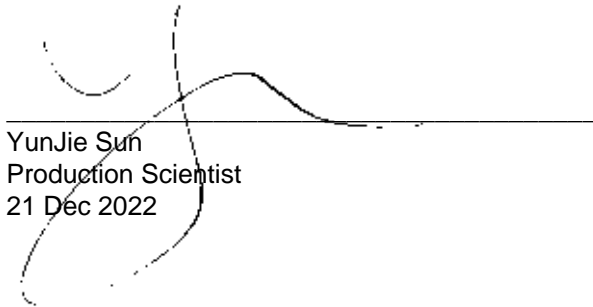
Styl-HF® Component List			
NEB Part Number	Component Description	Lot Number	Individual QC Result
R3500LVIAL	Styl-HF®	10175014	Pass
B7024AVIAL	Gel Loading Dye, Purple (6X)	10168649	Pass
B6004SVIAL	rCutSmart™ Buffer	10173160	Pass

Assay Name/Specification	Lot # 10175015
<b>Endonuclease Activity (Nicking)</b> A 50 µl reaction in CutSmart™ Buffer containing 1 µg of supercoiled PhiX174 DNA and a minimum of 20 Units of Styl-HF™ incubated for 4 hours at 37°C results in <10% conversion to the nicked form as determined by agarose gel electrophoresis.	Pass
<b>Exonuclease Activity (Radioactivity Release)</b> A 50 µl reaction in CutSmart™ Buffer containing 1 µg of a mixture of single and double-stranded [ <sup>3</sup> H] E. coli DNA and a minimum of 100 units of Styl-HF™ incubated for 4 hours at 37°C releases <0.1% of the total radioactivity.	Pass
<b>Non-Specific DNase Activity (16 Hour)</b> A 50 µl reaction in CutSmart™ Buffer containing 1 µg of Lambda DNA and a minimum of 100 Units of Styl-HF™ incubated for 16 hours at 37°C results in a DNA pattern free of detectable nuclease degradation as determined by agarose gel electrophoresis.	Pass
<b>Ligation and Recutting (Terminal Integrity)</b> After a 50-fold over-digestion of Lambda DNA with Styl-HF™, >95% of the DNA fragments can be ligated with T4 DNA ligase in 16 hours at 16°C. Of these ligated	Pass

Assay Name/Specification	Lot # 10175015
fragments, >95% can be recut with Styl-HF™.	

This product has been tested and shown to be in compliance with all specifications.

One or more products referenced in this document may be covered by a 3rd-party trademark. Please visit [www.neb.com/trademarks](http://www.neb.com/trademarks) for additional information.



YunJie Sun  
Production Scientist  
21 Dec 2022



Michael Tonello  
Packaging Quality Control Inspector  
27 Dec 2022